

Excellent Integrated System Limited

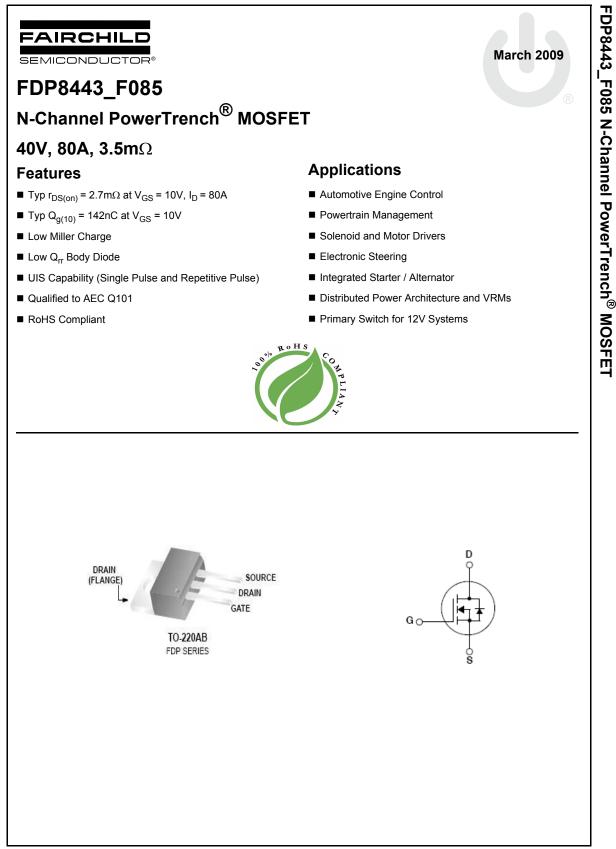
Stocking Distributor

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Fairchild Semiconductor FDP8443_F085

For any questions, you can email us directly: <u>sales@integrated-circuit.com</u>





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Symbol			Parame	ter					Rating	s	Units
/ _{DSS}	Drain to S	ource Voltage							40		V
/ _{GS}	Gate to Se	ource Voltage							±20		V
		rent Continuous (T ₀							80		
C	Continuou	is ($T_{amb} = 25^{\circ}C, V_{GS}$	_S = 10V, wit	h R _{θJA} =	= 62 ^o C/W)				20		Α
	Pulsed							S	ee Figu	re 4	
AS	Single Pu	lse Avalanche Ener	gy			(Nc	ote 1)		531		mJ
D	Power Dis	sipation							188		W
	Derate ab								1.25		W/ºC
T _J , T _{STG}	Operating	and Storage Temp	erature					-	55 to +1	75	°C
[herm	al Cha	racteristics									
	1										
۲ _{θJC}	Thermal F	Resistance Junction	to Case						0.8		°C/W
$R_{\theta JA}$	Thermal F	Resistance Junction	to Ambient	t		(No	te 2)		62		°C/W
Packa	ge Mar	king and Or	dering	Infor	mation						
Device	Marking	Device	Packa	ge	Reel Size	•	Тар	e Width		Quan	tity
FDF	P8443	FDP8443_F085	TO-220	AB	Tube			N/A		50 ur	nits
Symbol		Parameter			Test Condit			Min	Тур	Max	Units
Off Cha	racterist	ics									
Dff Cha B _{VDSS}		ource Breakdown \	/oltage	I _D = 25	60μΑ, V _{GS} = 0V	/		40		-	V
B _{VDSS}	Drain to S	ource Breakdown \		V _{DS} =	32V,			40	-	- 1	
BVDSS	Drain to S			V _{DS} = V _{GS} =	32V, 0V	/ T _C = 15	0°C	40 - -		- 1 250	V µA
B _{VDSS} DSS	Drain to S Zero Gate	ource Breakdown \	rent	V _{DS} =	32V, 0V		0°C	40 - - -	-	-	
BVDSS DSS GSS	Drain to S Zero Gate Gate to Se	ource Breakdown \ Voltage Drain Curr ource Leakage Curr	rent	V _{DS} = V _{GS} =	32V, 0V		0°C	-	- - -	250	μA
B _{VDSS} DSS GSS	Drain to S Zero Gate	ource Breakdown \ Voltage Drain Curr ource Leakage Curr	rent	V _{DS} = V _{GS} =	32V, 0V		0°C	-	-	250	μA
B _{VDSS} DSS GSS Dn Cha	Drain to S Zero Gate Gate to So racterist	ource Breakdown \ Voltage Drain Curr ource Leakage Curr	rent	V _{DS} = V _{GS} = V _{GS} =	32V, 0V	T _C = 15	0°C	-	- - - 2.8	250	μA
B _{VDSS} DSS GSS Dn Cha	Drain to S Zero Gate Gate to So racterist	ource Breakdown V Voltage Drain Curr purce Leakage Curr ics	rent	V_{DS} = V_{GS} = V_{GS} =	32V, 0V ±20V	T _C = 15	0°C	-		250 ±100	μA nA
B _{VDSS} DSS GSS	Drain to S Zero Gate Gate to S racterist Gate to S	ource Breakdown V Voltage Drain Curr purce Leakage Curr ics	rent rent Ditage	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V$	T _C = 15	0°C	2	2.8 2.7	250 ±100 4 3.5	μA nA
BVDSS DSS GSS Dn Cha / _{GS(th)}	Drain to S Zero Gate Gate to S racterist Gate to S	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo	rent rent Ditage	$V_{DS} =$ $V_{GS} =$ $V_{GS} =$ $V_{GS} =$ $I_D = 80$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V$	T _C = 15	0°C	- - - 2 -	2.8	250 ±100	μA nA V
BVDSS DSS DSS Dn Cha /GS(th) DS(on)	Drain to S Zero Gate Gate to S racterist Gate to S Drain to S	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Source On Resistan	rent rent Ditage	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V$	T _C = 15	0°C	- - - 2 -	2.8 2.7	250 ±100 4 3.5	μA nA V
B _{VDSS} DSS GSS Dn Cha / _{GS(th)} DS(on)	Drain to S Zero Gate Gate to S racterist Gate to S Drain to S	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo	rent rent Ditage	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V$	T _C = 15	0°C	- - - 2 -	2.8 2.7	250 ±100 4 3.5	μA nA V
3 _{VDSS} DSS GSS)n Cha / _{GS(th)} DS(on))ynami	Drain to S Zero Gate Gate to S racterist Gate to S Drain to S	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Gource On Resistan	rent rent Ditage	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V,$ $75^{\circ}C$	T _C = 15	0°C	- - - 2 -	2.8 2.7	250 ±100 4 3.5	μA nA V
B _{VDSS} DSS GSS Dn Cha V _{GS(th)} DS(on) D S(on) D S(on)	Drain to S Zero Gate Gate to S Gate to S Gate to S Drain to S C Charace Input Cap	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Gource On Resistan	rent rent Ditage	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$	T _C = 15	0°C	- - - 2 -	2.8 2.7 4.7	250 ±100 4 3.5	μA nA V mΩ
B _{VDSS} DSS GSS Dn Cha /GS(th) DS(on) DS(on) Dynami Ciss Coss	Drain to S Zero Gate Gate to S Gate to S Drain to S C Charac Input Cap Output Ca	ource Breakdown V voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Gource On Resistan cteristics	rent rent oltage ce	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$	T _C = 15	0°C	- - - 2 -	2.8 2.7 4.7 9310	250 ±100 4 3.5	μΑ nA V mΩ
B _{VDSS} DSS GSS Dn Cha V _{GS(th)} DS(on)	Drain to S Zero Gate Gate to S Gate to S Drain to S C Charac Input Cap Output Ca	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Source On Resistan cteristics pacitance apacitance Transfer Capacitance	rent rent oltage ce	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$ $V_{DS} = 1$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $A, V_{GS} = 10V$ $A, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$	T _C = 15 μΑ	0°C	- - - 2 -	2.8 2.7 4.7 9310 800	250 ±100 4 3.5	μA nA V mΩ pF pF
Byddss DSS GSS Dn Cha (GS(th) DS(on)	Drain to S Zero Gate Gate to S Gate to S Drain to S C Charac Input Cap Output Ca Reverse Gate Res	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Source On Resistan cteristics pacitance apacitance Transfer Capacitance	rent rent oltage ce	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$ $V_{DS} = 1$ f = 1MI $V_{GS} = V_{GS} = 1$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $DA, V_{GS} = 10V$ $DA, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$ Hz 0.5V, f = 1MHz 0 to 10V	T _C = 15 μΑ	0°C		2.8 2.7 4.7 9310 800 510	250 ±100 4 3.5 6.1 - -	μA nA V mΩ pF pF
Byddss DSS DSS DSS DN Cha (GS(th) DS(on) DS(Drain to S Zero Gate Gate to S Gate to S Gate to S Drain to S C Charae Input Cap Output Ca Reverse Gate Res Total Gate Threshold	ource Breakdown V Voltage Drain Curr burce Leakage Curr ics ource Threshold Vo Source On Resistan cteristics macitance apacitance Transfer Capacitance istance e Charge at 10V I Gate Charge	rent rent ce ce	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$ $V_{DS} = 1$ f = 1MI $V_{GS} = V_{GS} = 1$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $DA, V_{GS} = 10V$ $DA, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$ Hz 0.5V, f = 1MHz 0 to 10V	T _C = 15 μA /, z V _{DD} = 2			2.8 2.7 4.7 9310 800 510 0.9	250 ±100 4 3.5 6.1 - - - -	μA nA V mΩ pF pF pF
3vDSS DSS GSS Dn Cha /GS(th) DS(on)	Drain to S Zero Gate Gate to S Gate to S Gate to S Drain to S C Charac Input Cap Output Ca Reverse Gate Res Total Gate Threshold Gate to S	ource Breakdown V Voltage Drain Curr ource Leakage Curr ics ource Threshold Vo Source On Resistan cteristics macitance apacitance apacitance istance a Charge at 10V I Gate Charge ource Gate Charge	rent rent ce ce	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$ $V_{DS} = 1$ f = 1MI $V_{GS} = V_{GS} = 1$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $DA, V_{GS} = 10V$ $DA, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$ Hz 0.5V, f = 1MHz 0 to 10V	T _C = 15 μA /, z V _{DD} = 20 I _D = 35	0V - 5A		2.8 2.7 4.7 9310 800 510 0.9 142	250 ±100 4 3.5 6.1 - - - 185	μA nA V mΩ pF pF Ω nC
B _{VDSS} DSS GSS Dn Cha (GS(th) DS(on)	Drain to S Zero Gate Gate to S Gate to S Gate to S Drain to S C Charac Input Cap Output Ca Reverse Gate Res Total Gate Threshold Gate to S	ource Breakdown V Voltage Drain Curr burce Leakage Curr ics ource Threshold Vo Source On Resistan cteristics macitance apacitance Transfer Capacitance istance e Charge at 10V I Gate Charge	rent rent ce ce	$V_{DS} = V_{GS} = V_{GS} = V_{GS} = I_D = 80$ $I_D = 80$ $T_J = 17$ $V_{DS} = 1$ f = 1MI $V_{GS} = V_{GS} = 1$	32V, 0V $\pm 20V$ $V_{DS}, I_D = 250\mu$ $DA, V_{GS} = 10V$ $DA, V_{GS} = 10V,$ $75^{\circ}C$ 25V, $V_{GS} = 0V$ Hz 0.5V, f = 1MHz 0 to 10V	T _C = 15 μA /, z V _{DD} = 2	0V - 5A	- - - - - - - - - - - - - -	2.8 2.7 4.7 9310 800 510 0.9 142 17.5	250 ±100 4 3.5 6.1 - - - 185 23	μΑ nA V mΩ pF pF pF Ω nC nC

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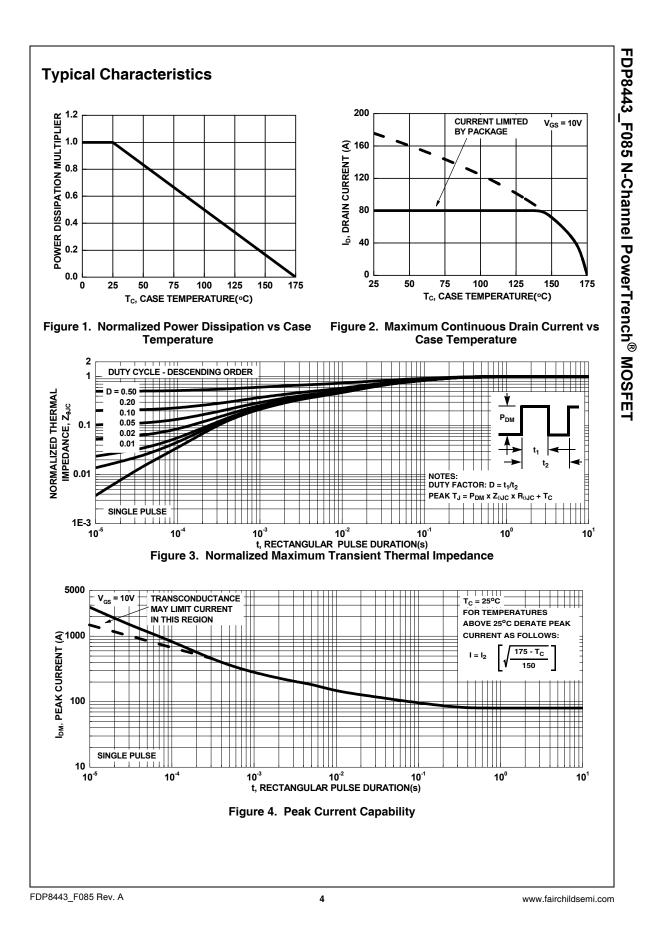
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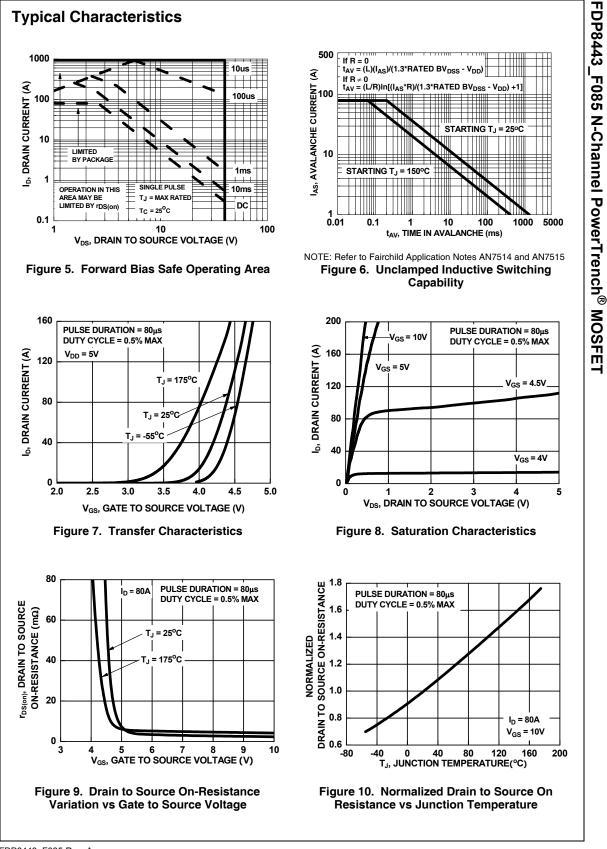
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Switch	ing Characteristics (V _{GS}	= 10V)				
t _{on}	Turn-On Time		-	-	58	ns
t _{d(on)}	Turn-On Delay Time	V_{DD} = 20V, I _D = 35A V_{GS} = 10V, R _{GS} = 2Ω	-	18.4	-	ns
t _r	Rise Time		-	17.9	-	ns
t _{d(off)}	Turn-Off Delay Time		-	55	-	ns
t _f	Fall Time		-	13.5	-	ns
t _{off} Drain-So	Turn-Off Time Diode Characteristics		-	-	109	ns
Drain-So	ource Diode Characteristics	I _{SD} = 35A	-	- 0.8	109	
				- 0.8 0.8		ns - V
Drain-So	ource Diode Characteristics	I _{SD} = 35A	-		1.25	

This product has been designed to meet the extreme test conditions and environment demanded by the automotive industry. For a copy of the requirements, see AEC Q101 at: http://www.aecouncil.com/ All Fairchild Semiconductor products are manufactured, assembled and tested under ISO9000 and QS9000 quality systems certification.



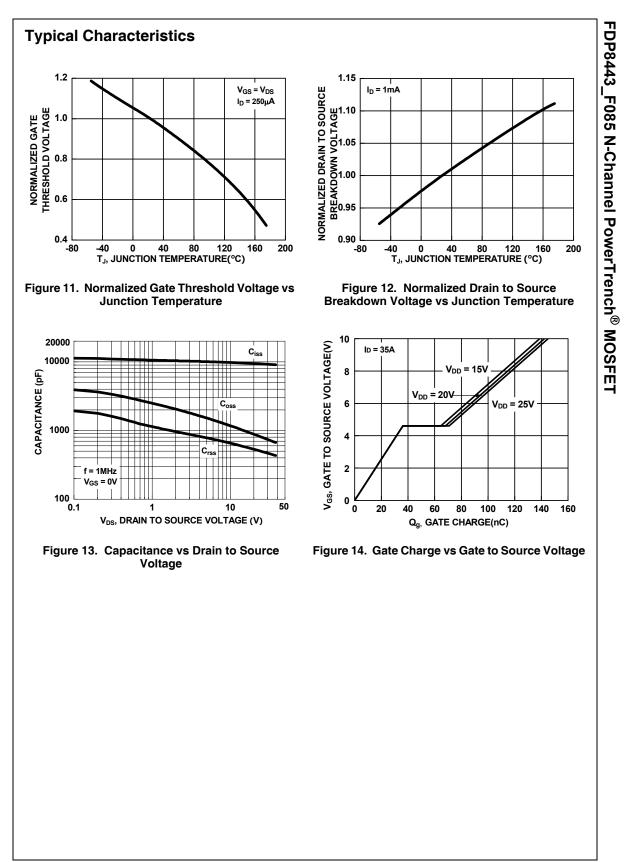






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